


<b>Search Notes</b>  	<b>Application/Control No.</b>  10015247	<b>Applicant(s)/Patent Under Reexamination</b>  LEUNG ET AL.
	<b>Examiner</b>  Revak, Christopher A	<b>Art Unit</b>  2131

### SEARCHED

Class	Subclass	Date	Examiner
none	none	9/11/07	CR

### SEARCH NOTES

Search Notes	Date	Examiner
BRS Text Search: USPAT, US PGPUB, USOCR, DERWENT, IBM TDB, FPRS, EPO, JPO (see attached strategy)	9/11/07; 2/25/08	CR
BRS Subclass Text Search: USPAT, US PGPUB (see attached strategy)	9/11/07	CR
DIALOG Text Search: COMPSCI, ELECTRON, SOFTWARE (see attached strategy)	2/25/08	CR
Interference Search (see attached strategy)	2/25/08	CR

### INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
380	255,259,270	2/25/08	CR
713	150,168,171	2/25/08	CR
726	2,3,14	2/25/08	CR